Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/790,142	SENDAI ET AL.
Examiner	Art Unit
Shun Lee	2884

SEARCHED					
Class	Subclass	Date	Examiner		
250	252.1	3/15/2006	SL		
378	207	3/15/2006	SL		
			<u>-</u>		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST (US-PGPUB, USPAT, USOCR, EPO, JPO, IBM_TDB) - See Search History Printout	3/15/2006	SL		